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(54) Title: LINEWIDTH MEASUREMENT SYSTEM

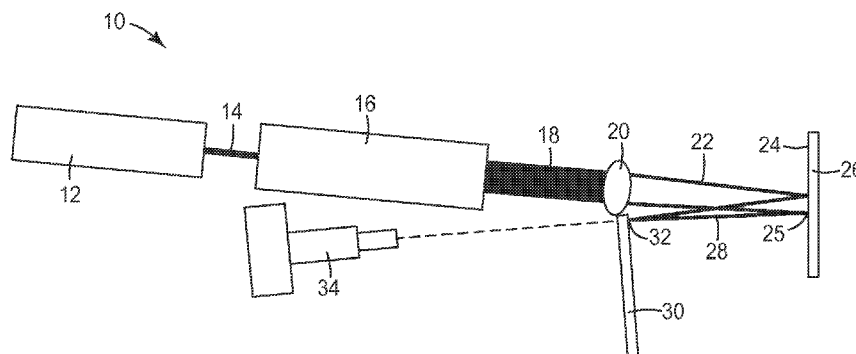


FIG. 1

(57) Abstract: A method includes passing an interrogating light beam through a Fourier transform lens and onto the surface of a material to form a Fraunhofer diffraction pattern of one or more surface features of the material. An image of the diffraction pattern is processed to determine the dimensions of the feature.